

CE/EMC TEST REPORT

For

EXTRA LIGHTING MANUFACTURING LTD.

Product Name:	LED PANEL LIGHT UGR<19
Trademark:	N/A
Model Number:	RH-PL6262 UGR<19 RH-PL6262, RH-PL3030, RH-PL3060, RH-PL3012, RH-PL6060, RH-PL60120, RH-RPL, RH-SPL, RH-MRD, RH-MSD, RH-SOP, RH-ROP, RH-RUS, RH-SUS
Prepared For:	EXTRA LIGHTING MANUFACTURING LTD.
Address:	NO. 19 Yunpu 1st Road Yunpu Industrial Zone, Guangzhou, 510530 China
Prepared By:	Shenzhen BCTC Testing Co., Ltd.
Address:	BCTC Building & 1-2F, East of B Building, Pengzhou Industrial, Fuyuan 1st Road, Qiaotou Community, Fuyong Street, Bao'an District, Shenzhen, China
Report No.:	BCTC-FY170503280E



TABLE OF CONTENT

	st Report Declaration	Page
1.	GENERAL INFORMATION	5
	.1. Description of Device (EUT)	
1	.2. Tested System Details	
	.3. Test Uncertainty	
	.4. Test Facility	
2.	TEST INSTRUMENT USED	7
3.	CONDUCTED EMISSION AT THE MAINS TERMINALS TEST	
3	B.1. Block Diagram Of Test Setup	
-	3.2. Test Standard	
	8.3. Power Line Conducted Emission Limit	
	8.4. EUT Configuration on Test	
	8.5. Operating Condition of EUT	
	8.6. Test Procedure 8.7. Test Result	
	MAGNETIC EMISSION TEST	
	.1. Block Diagram Of Test Setup	
	 Test Standard Power Line Conducted Emission Limit 	
	4. EUT Configuration on Test	
	4.5. Operating Condition of EUT	
	.6. Test Procedure	
	.7. Test Result	
5.	RADIATION EMISSION TEST	
	5.1. Block Diagram of Test Setup	
-	5.2. Test Standard	
5	5.3. Radiation Limit	19
5	5.4. EUT Configuration on Test	
	5.5. Operating Condition of EUT	
	.6. Test Procedure	
-	5.7. Test Result	
6.	HARMONIC CURRENT EMISSION TEST	
-	5.1. Block Diagram of Test Setup	
	5.2. Test Standard	
	5.3. Operating Condition of EUT	
	6.4. Test Procedure	
	5.5. Test Results	
	VOLTAGE FLUCTUATIONS & FLICKER TEST	
	7.1. Block Diagram of Test Setup	
	7.2. Test Standard	
	 Operating Condition of EUT	
	 Test Results	
	ELECTROSTATIC DISCHARGE IMMUNITY TEST	
	 Block Diagram of Test Setup Test Standard 	
	8.3. Severity Levels and Performance Criterion	
	8.4. EUT Configuration	
	8.5. Operating Condition of EUT	



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Beile	Shenzhen BCTC Testing Co., Ltd.	Report No.: BCTC-FY170503280E
8.6.	Test Procedure	
8.7.	Test Results	
. RF	FIELD STRENGTH SUSCEPTIBILITY TEST	
9.1.	Block Diagram of Test Setup	
9.2.	Test Standard	
9.3.	Severity Levels and Performance Criterion	
9.4.	EUT Configuration on Test	
9.5. 9.6.	Operating Condition of EUT Test Procedure	
9.6. 9.7.	Test Results	
	ELECTRICAL FAST TRANSIENT/BURST IMM	
-		
10.1.	Block Diagram of EUT Test Setup	
10.2. 10.3.	Test Standard Severity Levels and Performance Criterion	
10.3.	EUT Configuration on Test	
10.4.	Operating Condition of EUT	
10.6.	Test Procedure	
10.7.	Test Results	
	SURGE TEST	
 11.1.	Block Diagram of EUT Test Setup	
11.2.	Test Standard	
11.3.	Severity Levels and Performance Criterion	
11.4.	EUT Configuration on Test	
11.5.	Operating Condition of EUT	
11.6.	Test Procedure	
11.7.	Test Result	
2.	INJECTED CURRENTS SUSCEPTIBILITY TES	ST41
12.1.	Block Diagram of EUT Test Setup	
12.2.	Test Standard	
12.3.	Severity Levels and Performance Criterion	
12.4.	EUT Configuration on Test	
12.5.	Operating Condition of EUT	
12.6.	Test Procedure	
12.7.	Test Result	
	MAGNETIC FIELD IMMUNITY TEST	
13.1.	Block Diagram of Test Setup	
13.2.	Test Standard	
13.3. 13.4.	Severity Levels and Performance Criterion	
13.4.	EUT Configuration on Test Operating Condition of EUT	
13.6.	Test Procedure	
13.7.	Test Results	
	VOLTAGE DIPS AND INTERRUPTIONS TEST	-
 14.1.	Block Diagram of EUT Test Setup	
14.1.	Test Standard	
14.2.	Severity Levels and Performance Criterion	
14.4.	EUT Configuration on Test	
14.5.	Operating Condition of EUT	
14.6.	Test Procedure	
14.7.	Test Result	
5.	EUT PHOTOGRAPHS	
	EUT TEST PHOTOGRAPHS	



Shenzhen BCTC Testing Co., Ltd.

Applicant	:	EXTRA LIG	GHTING MANUFA	ACTURING LTD.		
Address	:	NO. 19 Yu 510530 Ch		npu Industrial Zone	e, Guangzhou,	
Manufacturer	'n	EXTRA LIG	GHTING MANUFA	ACTURING LTD.		
Address	:	NO. 19 Yu 510530 Ch		npu Industrial Zone	e, Guangzhou,	
EUT	:	LED PANE	L LIGHT UGR<1	9		
Model Number	:	RH-PL6012	2, RH-PL3030, RI	SPL, RH-MRD, RH	3012, RH-PL6060, H-MSD, RH-SOP,	
Trademark:	:	N/A				
Test Date	:	May 27 – J	un. 02, 2017			
Date of Report	:	Jun. 02, 20	17			
Test Result:	÷		ment under tes		be compliance with the	е
Test Procedure	e Us	sed:				
EMI	:	EN 55015:	2013+A1:2015			
		EN 61000-	3-2:2014, EN 610	00-3-3:2013		
EMS	:	EN 61547:	2009			
				00-4-3:2006+A1:2	2008+A2:2010,	
			4-4:2012, EN 610			
		EN 61000-	4-6:2014, EN 610	000-4-8:2010, EN 6	51000-4-11:2004	
Prepared by	′(Er	ngineer):	Kelsey Tan	kelsey Tom	检	
Reviewer(S	upe	ervisor):	Jade Yang	Jade long	CTC	
Approved(I	Ma	nager).	Carson Zhang	Con she	N GO	
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This test report is based on a single evaluation of one sample of above mentioned products. It is not permitted to be duplicated in extracts without written approval of Shenzhen BCTC Testing Co., Ltd.



1. GENERAL INFORMATION

1.1.Description of Device (EUT)

EUT :	LED PANEL LIGHT UGR<19
Trademark :	N/A
Model Number :	RH-PL6262 UGR<19 RH-PL6262, RH-PL3030, RH-PL3060, RH-PL3012, RH-PL6060, RH-PL60120, RH-RPL, RH-SPL, RH-MRD, RH-MSD, RH-SOP, RH-ROP, RH-RUS, RH-SUS
Model Difference	The product is different for model number and outlook color.
Power Supply : Note: LED PANEL LIGI recorded in this report.	Input:AC 220-240V 50/60Hz Max:0.4A Output:DC27-40V 40W HT UGR<19 was selected as the test model and the datas have been

1.2. Tested System Details

None.

1.3. Test Uncertainty

Conducted Emission Uncertainty

±2.66dB

Radiated Emission Uncertainty: ±4.26dB





Report No.: BCTC-FY170503280E

1.4.Test Facility

Site Description		
Name of Firm	:	Shenzhen BCTC Testing Co., Ltd.
Site Location	:	BCTC Building & 1-2F, East of B Building, Pengzhou Industrial, Fuyuan 1st Road, Qiaotou Community, Fuyong Street, Bao'an District, Shenzhen, China
Lab Qualifications	2	Certificated by Industry Canada Registration No.: 12655A Date of registration: January 19, 2015 Certificated by FCC, USA Registration No.: 187086 Date of registration: November 28, 2014
		Certificated by CNAS China Registration No.: CNAS L6046 Date of registration: February 3, 2013



2. TEST INSTRUMENT USED

For Conducted Emission at the mains terminals Test

Conducted Emission Test (A site)							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
843 Shielded Room	ChengYu	843 Room	843	Aug. 25, 2016	Aug. 24, 2017		
EMI Receiver	R&S	ESCI	101421	Aug. 27, 2016	Aug. 26, 2017		
LISN	Schwarzbeck	NSLK8127	8127739	Sep. 07, 2016	Sep. 06, 2017		
Attenuator	R&S	ESH3-Z2	BCTC021E	Aug. 25, 2016	Aug. 24, 2017		
843 Cable 1#	FUJIKURA	843C1#	001	Aug. 25, 2016	Aug. 24, 2017		

For Magnetic Emission Test

Conducted Emission Test (A site)								
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.			
843 Shielded Room	ChengYu	843 Room	843	Aug. 25, 2016	Aug. 24, 2017			
EMI Receiver	R&S	ESCI	101421	Aug. 27, 2016	Aug. 26, 2017			
Three-loop antenna	DAZE	ZN30401	13017	Aug. 25, 2016	Aug. 24, 2017			
Attenuator	R&S	ESH3-Z2	BCTC021E	Aug. 25, 2016	Aug. 24, 2017			
843 Cable 2#	FUJIKURA	843C1#	002	Aug. 25, 2016	Aug. 24, 2017			

For Radiated Emission Test

	Radiation Emission Test (966 chamber)							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.			
966 chamber	ChengYu	966 Room	966	Aug. 25, 2016	Aug. 24, 2017			
Spectrum Analyzer	Agilent	E4407B	MY45109572	Aug. 27, 2016	Aug. 26, 2017			
Amplifier	Schwarzbeck	BBV9743	9743-119	Aug. 25, 2016	Aug. 24, 2017			
Amplifier	Schwarzbeck	BBV9718	9718-270	Aug. 25, 2016	Aug. 24, 2017			
Log-periodic Antenna	Schwarzbeck	VULB9160	VULB9160-3 369	Sep. 07, 2016	Sep. 06, 2017			
EMI Receiver	R&S	ESCI	101421	Aug. 27, 2016	Aug. 26, 2017			
Horn Antenna	Schwarzbeck	BBHA9120D	9120D-1275	Aug. 25, 2016	Aug. 24, 2017			
966 Cable 1#	CHENGYU	966	004	Aug. 25, 2016	Aug. 24, 2017			
966 Cable 2#	CHENGYU	966	003	Aug. 25, 2016	Aug. 24, 2017			



For Harmonic & Flicker Test

For Harmonic / Flicker Test (A site)							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
Harmonic / Flicker Analyzer	KIKUSUI	KHA1000	VA002445	Sep. 07, 2016	Sep. 06, 2017		
AC Power Supply	KIKUSUI	PCR4000M	UK001879	Sep. 07, 2016	Sep. 06, 2017		
Line Impedance network	KIKUSUI	LIN1020JF	UL001611	Sep. 07, 2016	Sep. 06, 2017		

For Electrostatic Discharge Immunity Test

For Electrostatic Discharge Immunity Test (A site)							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
ESD Tester	KIKISUI	KES4201A	UH002321	Aug. 28, 2016	Aug. 27, 2017		

For RF Field Strength Susceptibility Test(SMQ)

For RF Field Strength Susceptibility Test (SMQ site)							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
Signal Generator	HP	8648A	3625U00573	Sep. 26, 2016	Sep. 26, 2017		
Amplifier	A&R	500A100	17034	Sep. 26, 2016	Sep. 26, 2017		
Amplifier	A&R	100W/1000M1	17028	Sep. 26, 2016	Sep. 26, 2017		
Audio Analyzer (20Hz~1GHz)	Panasonic	2023B	202301/428	Sep. 26, 2016	Sep. 26, 2017		
Isotropic Field Probe	A&R	FP2000	16755	Sep. 26, 2016	Sep. 26, 2017		
Antenna	EMCO	3108	9507-2534	Sep. 26, 2016	Sep. 26, 2017		
Log-periodic Antenna	A&R	AT1080	16812	Sep. 26, 2016	Sep. 26, 2017		

For Electrical Fast Transient /Burst Immunity Test

For Electrical Fast Transient/Burst Immunity Test (A site)									
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.				
Burst Tester	Prima	EFT61004AG	PR14054467	Aug. 27, 2016	Aug. 26, 2017				
Coupling Clamp	Prima	EFT61004AG	BCTC009E	Aug. 27, 2016	Aug. 26, 2017				



For Surge Test

For Surge Test (A site)							
Equipment	Equipment Manufacturer Model# Serial# Last Cal. Next						
Surge Tester	Prima	SUG61005BX	PR12045446	Aug. 27, 2016	Aug. 26, 2017		

For Injected Currents Susceptibility Test

	For Injected Currents Susceptibility Test (A site)										
Equipment	Manufacturer	Last Cal.	Next Cal.								
C/S Test System	SCHLODER	CDG600	126B1281	Aug. 27, 2016	Aug. 26, 2017						
CDN	SCHLODER	CDN-M2+3	A2210320/20 15	Aug. 27, 2016	Aug. 26, 2017						
Injection Clamp	SCHLOBER	EMCL-20	132A1214/20 15	Aug. 27, 2016	Aug. 26, 2017						

For Magnetic Field Immunity Test

	For Magnetic Field Immunity Test (A site)								
Equipment	Equipment Manufacturer Model# Serial# Last Cal. Next Cal.								
Magnetic field generator	HTEC	HPFMF	15701	Aug. 27, 2016	Aug. 26, 2017				

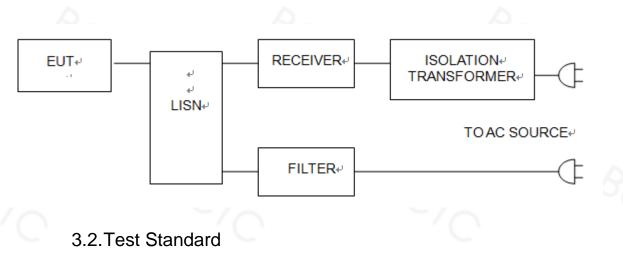
For Voltage Dips Interruptions Test

For Voltage Dips Interruptions Test (A site)								
Equipment Manufacturer Model# Serial# Last Cal. Next Cal.								
Dips Tester	Prima	DRP61011AG	PR14086284	Aug. 27, 2016	Aug. 26, 2017			



3. CONDUCTED EMISSION AT THE MAINS TERMINALS TEST

3.1.Block Diagram Of Test Setup



EN 55015:2013+A1:2015

3.3. Power Line Conducted Emission Limit

	Frequency		ency	Limits dB(µV)				
2	MHz			Quasi-peak Level	Average Level			
	0.009	~	0.05	110	N/A			
	0.05	2	0.15	90 ~ 80*	N/A			
	0.15	2	0.50	66 ~ 56*	56 ~ 46*			
	0.50	2	5.00	56	46			
	5.00	~	30.00	60	50			

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

3.4. EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN55015 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

3.5. Operating Condition of EUT

- 3.5.1 Setup the EUT and simulators as shown in Section 3.1.
- 3.5.2 Turn on the power of all equipments.

3.5.3 Let the EUT work in test modes and test it.



3.6.Test Procedure

The EUT is put on the ground and connected to the AC mains through a Artificial Mains Network (AMN). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission levels according to the **EN55015** regulations during conducted emission test.

The bandwidth of the test receiver (R&S Test Receiver ESCI) is set at 10KHz.

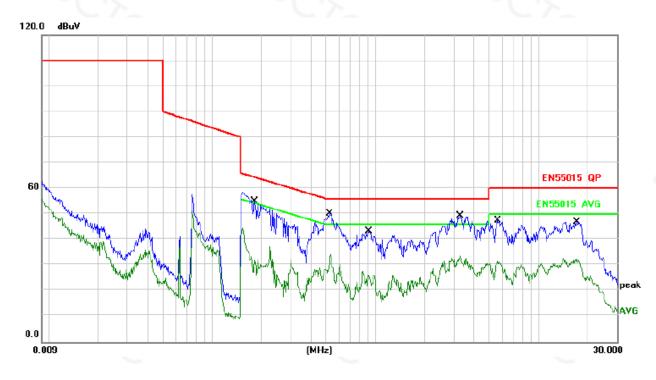
The frequency range from 150 KHz to 30 MHz is investigated.

3.7.Test Result

PASS Please refer to the following page.



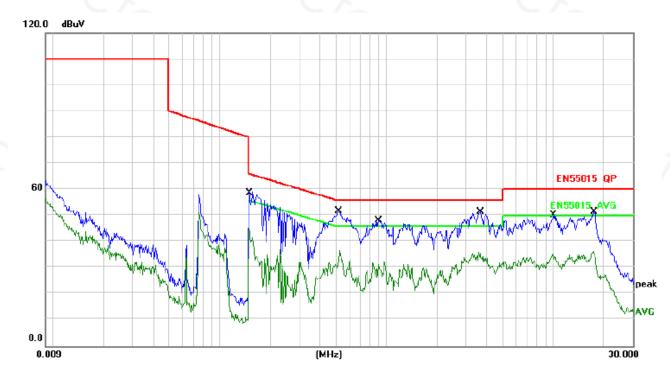
Conducted Emission At The Mains Terminals Test Data									
Temperature:	24.5 ℃	Relative Humidity:	54%						
Pressure:	1009hPa	Phase :	Lin						
Test Voltage : AC 230V/50Hz Test Mode: ON Mode									



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.1819	45.34	9.67	55.01	64.39	-9.38	QP	
2		0.1819	22.57	9.67	32.24	54.39	-22.15	AVG	
3	*	0.5220	40.54	9.68	50.22	56.00	-5.78	QP	
4		0.5220	24.74	9.68	34.42	46.00	-11.58	AVG	
5		0.9060	33.72	9.70	43.42	56.00	-12.58	QP	
6		0.9060	16.68	9.70	26.38	46.00	-19.62	AVG	
7		3.2980	39.51	9.72	49.23	56.00	-6.77	QP	
8		3.2980	23.91	9.72	33.63	46.00	-12.37	AVG	
9		5.7020	37.18	9.76	46.94	60.00	-13.06	QP	
10		5.7020	21.51	9.76	31.27	50.00	-18.73	AVG	
11		17.1100	37.15	9.95	47.10	60.00	-12.90	QP	
12		17.1100	22.49	9.95	32.44	50.00	-17.56	AVG	



Conducted Emission At The Mains Terminals Test Data									
Temperature:	24.5 ℃	Relative Humidity:	54%						
Pressure:	1009hPa	Phase :	Neutral						
Test Voltage : AC 230V/50Hz Test Mode: ON Mode									

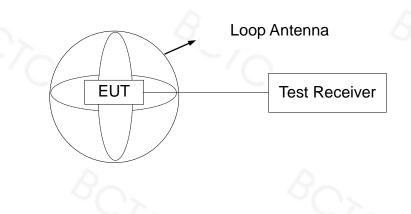


No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.1527	49.50	9.73	59.23	65.85	-6.62	QP	
2		0.1527	32.13	9.73	41.86	55.85	-13.99	AVG	
3	*	0.5180	42.06	9.68	51.74	56.00	-4.26	QP	
4		0.5180	27.02	9.68	36.70	46.00	-9.30	AVG	
5		0.9020	38.54	9.70	48.24	56.00	-7.76	QP	
6		0.9020	21.57	9.70	31.27	46.00	-14.73	AVG	
7		3.6620	41.58	9.73	51.31	56.00	-4.69	QP	
8		3.6620	25.94	9.73	35.67	46.00	-10.33	AVG	
9		10.0380	40.54	9.84	50.38	60.00	-9.62	QP	
10		10.0380	25.43	9.84	35.27	50.00	-14.73	AVG	
11		17.4500	41.46	9.95	51.41	60.00	-8.59	QP	
12		17.4500	26.63	9.95	36.58	50.00	-13.42	AVG	



4. MAGNETIC EMISSION TEST

4.1.Block Diagram Of Test Setup



4.2.Test Standard

EN 55015:2013+A1:2015

4.3. Power Line Conducted Emission Limit

Frequency		ncy	Limits dB(µA)
MHz			Quasi-peak Level
0.009	~	0.07	88
0.07	~	0.15	88 ~ 58*
0.15	~	0.50	58 ~ 22*
0.50	~	5.00	22

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

4.4.EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN55015 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

4.5. Operating Condition of EUT

4.5.1 Setup the EUT and simulators as shown in Section 4.1.

4.5.2 Turn on the power of all equipments.

4.5.3 Let the EUT work in test modes and test it.



4.6.Test Procedure

The EUT is placed on a wood table in the center of a loop antenna. The induced current in the loop antenna is measured by means of a current probe and the test receiver. Three field components is checked by means of a coax switch.

The frequency range from 9KHz to 30MHz is investigated. The receiver is measured with the quasi-peak detector. For frequency band 9KHz to 150KHz, the bandwidth of the field strength meter (R&S Test Receiver ESCI) is set at 200Hz. For frequency band 150KHz to 30MHz, the bandwidth is set at 10KHz.

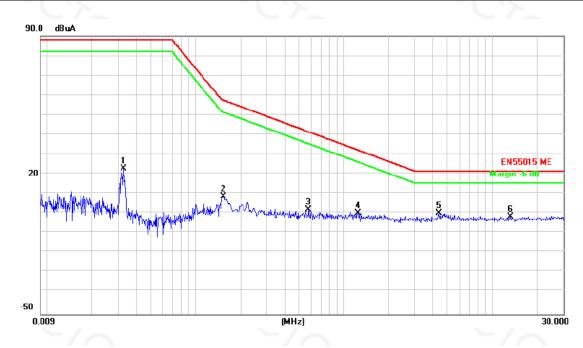
4.7.Test Result

PASS

Please refer to the following page.



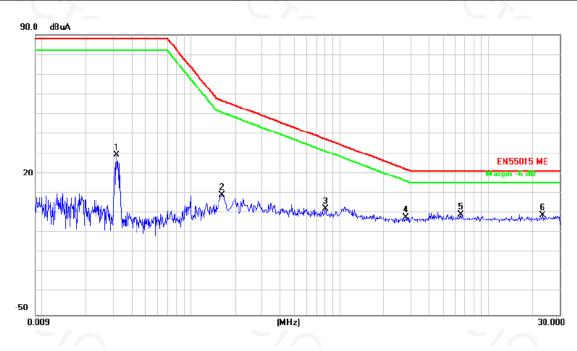
Magnetic Emission Test Data									
Temperature:24.5 °CRelative Humidity:54%									
Pressure:	1009hPa	Ant. Polarity	Х						
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode						



No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuA	dB	dBuA	dBuA	dB	Detector	Comment
1	0.0330	1.12	22.27	23.39	88.00	-64.61	QP	
2	0.1540	-17.77	27.00	9.23	57.68	-48.45	QP	
3	0.5820	-24.33	27.00	2.67	41.71	-39.04	QP	
4	1.2460	-26.09	27.00	0.91	32.56	-31.65	QP	
5 *	4.3540	-26.16	27.00	0.84	22.00	-21.16	QP	
6	13.2740	-27.70	27.00	-0.70	22.00	-22.70	QP	



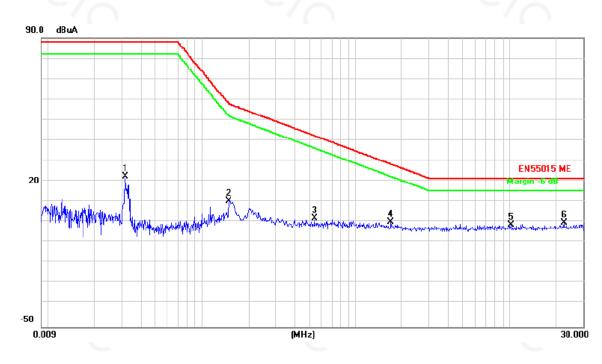
	Magnetic Emission Test Data									
Temperature:	24.5 ℃	Relative Humidity:	54%							
Pressure:	1009hPa	Ant. Polarity	Y							
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode							



No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuA	dB	dBuA	dBuA	dB	Detector	Comment
1	0.0317	7.41	22.44	29.85	88.00	-58.15	QP	
2	0.1620	-16.96	27.00	10.04	57.08	-47.04	QP	
3	0.8100	-23.99	27.00	3.01	37.73	-34.72	QP	
4	2.8060	-28.05	27.00	-1.05	22.80	-23.85	QP	
5 *	6.5220	-26.80	27.00	0.20	22.00	-21.80	QP	
6	22.9900	-27.29	27.00	-0.29	22.00	-22.29	QP	



	Magnetic Emission Test Data									
Temperature:	24.5 ℃	Relative Humidity:	54%							
Pressure:	1009hPa	Ant. Polarity	Z							
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode							

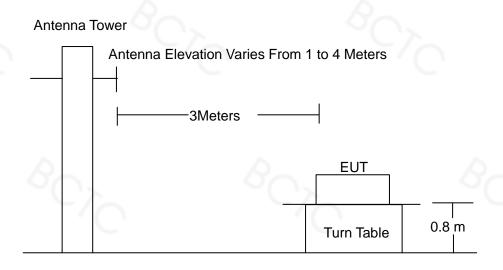


No	. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuA	dB	dBuA	dBuA	dB	Detector	Comment
1		0.0316	0.45	22.45	22.90	88.00	-65.10	QP	
2		0.1500	-15.87	27.00	11.13	58.00	-46.87	QP	
3		0.5380	-24.29	27.00	2.71	42.65	-39.94	QP	
4		1.6940	-25.95	27.00	1.05	28.87	-27.82	QP	
5		10.2620	-27.53	27.00	-0.53	22.00	-22.53	QP	
6	×	22.5820	-26.57	27.00	0.43	22.00	-21.57	QP	



5. RADIATION EMISSION TEST

5.1.Block Diagram of Test Setup



Ground Plane

5.2. Test Standard

EN 55015:2013+A1:2015

5.3. Radiation Limit

Frequency MHz	Distance (Meters)	Field Strengths Limits dB(µV)/m				
$30~\sim~230$	3	40.0				
230 \sim 300	3	47.0				

Remark:

(1) Emission level (dB(μ V)/m) = 20 log Emission level (μ V/m)

(2) The smaller limit shall apply at the cross point between two frequency bands.

(3) Distance refers to the distance in meters between the measuring instrument, antenna and the closed point of any part of the device or system.

5.4. EUT Configuration on Test

The EN55015 regulations test method must be used to find the maximum emission during radiated emission test.

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.2.



5.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.2 except the test set up replaced as Section 4.1.

5.6.Test Procedure

The EUT and its simulators are placed on a turned table that is 0.8 meter above the ground. The turned table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna that is mounted on the antenna tower. The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level. Broadband antenna (calibrated biconical and log periodical antenna) is used as receiving antenna. Both horizontal and vertical polarization of the antenna is set on test. In order to find the maximum emission levels, the interface cable must be manipulated according to EN55015 on radiated emission test.

The bandwidth setting on the field strength meter (R&S Test Receiver ESCI) is set at 120KHz.

The frequency range from 30MHz to 300MHz is checked.

5.7.Test Result

PASS Please refer to the following page.



	Radiation Emission Test Data									
Temperature:	24.5 ℃	Relative Humidity:	54%							
Pressure:	1009hPa	Phase :	Horizontal							
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode							

80.0 dBuV/m EN55015_03_QP Margin -6 dB 40 6 0.0 300.000 30.000 40 50 60 70 80 (MHz) 200

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector	cm	degree	Comment
1		47.3283	35.98	-14.74	21.24	40.00	-18.76	QP			
2		72.4637	49.62	-19.82	29.80	40.00	-10.20	QP			
3		88.9448	50.02	-18.49	31.53	40.00	-8.47	QP			
4	*	110.4387	52.92	-16.54	36.38	40.00	-3.62	QP			
5		177.4685	49.38	-17.98	31.40	40.00	-8.60	QP			
6		234.4883	38.29	-14.36	23.93	47.00	-23.07	QP			





	Radiation Emission Test Data									
Temperature:	24.5 ℃	Relative Humidity:	54%							
Pressure:	1009hPa	Phase :	Vertical							
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode							

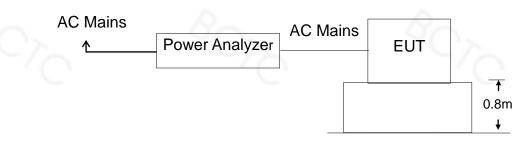


No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector	cm	degree	Comment
1	*	44.4755	51.39	-14.85	36.54	40.00	-3.46	QP			
2	İ	65.9358	52.62	-17.13	35.49	40.00	-4.51	QP			
3		95.3062	47.08	-17.17	29.91	40.00	-10.09	QP			
4		129.4556	46.20	-19.48	26.72	40.00	-13.28	QP			
5		180.7679	45.00	-17.68	27.32	40.00	-12.68	QP			
6	:	253.0004	31.94	-13.64	18.30	47.00	-28.70	QP			



6. HARMONIC CURRENT EMISSION TEST

6.1. Block Diagram of Test Setup



6.2. Test Standard

EN 61000-3-2:2014

- 6.3. Operating Condition of EUT
 - 6.3.1 Setup the EUT as shown in Section 6.1.
 - 6.3.2 Turn on the power of all equipments.
 - 6.3.3 Let the EUT work in test mode and test it.

6.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

6.5. Test Results

PASS Please refer to the following page.



Report No.: BCTC-FY170503280E

TTi HA1600 POWER & HARMON e Settings Help	IICS ANALYSE	R HA-PC Link Plus														
A-PC Link Version 3.01			N	Filtered	Limit	Ava	%Limit	Max	%Limif	II N	Filtered	Limit	Ava	%Limit I	Max	%Limit
A1600 Firmware Issue 3.02			1	172.0	Cirin /	try.	-	india.	-	2	-	1080.0	0.7	0.1	0.76	0.1
			3	13.40	2300.0	13.5	0.6	13.66	0.6 🗸	4	0.67	430.0	0.7	0.2	0.70	0.2 🗸
quipment under Test			5	6.17	1140.0	6.1	0.5	6.18	0.5 1	6	0.65	300.0	0.7	0.2	0.69	0.2 1
			7	5.01	770.0	5.0	0.6	5.05	0.7 🗸	8	0.71	230.0	0.7	0.3	0.75	0.3 🗸
- del Marchael			9	2.20	400.0	2.2	0.6	2.27	0.6 🗸	10	0.62	184.0	0.6	0.3	0.67	0.4 🗸
erial Number Tested b	ру		11	2.96	330.0	3.0	0.9	3.01	0.9 🗸	12		153.3	0.6		0.62	0.4 🗸
			13	3.29	210.0	3.3	1.6	3.31	1.6 🗸	14	1	131.4	0.6	0.5	0.62	0.5 🗸
			15	3.61	150.0	3.6	2.4	3.64	2.4 🗸	16		115.0	0.5	0.4	0.56	0.5 🗸
easurement		Date and Time of Test	17	2.29	132.3	2.3	1.7	2.33		18		102.2	0.5	0.5	0.53	0.5 🗸
N61000-3-2 (Harmonics)	-	2六月2017 11:02	19	1.51	118.4	1.5	1.3	1.57		20		92.0	0.5	0.5	0.51	0.6 🗸
			21	0.89	107.1	0.9	0.8	0.94	0.9 🗸			83.6	0.4		0.44	0.5 🗸
Iominal Voltage 230 Volts		Nominal Frequency	23	0.68	97.8	0.7	0.7	0.70	0.7 🗸			76.7	0.4	0.5	0.44	0.6 🗸
ioninal voltage 1250 volta		🤨 50 Hz 🔿 60 Hz	25	1.88	90.0	1.9	2.1	1.92		26		70.8	0.4	0.6	0.40	0.6 🗸
			27	2.16	83.3	2.2	2.6	2.21	2.7 ✓			65.7	0.3		0.35	0.5 🗸
			29	0.96	77.6	1.0	1.3	1.01	1.3 🗸			61.3	0.3	0.5	0.33	0.5 🗸
armonics Settings			31	0.15	72.6	0.2	0.3	0.16		32		57.5	0.2		0.25	0.4
			33	0.08	68.2	0.1	0.1	0.15	0.2 ✓			54.1	0.2		0.19	0.4
	tandard (>25W	/) to Table 2 🔹	35	0.93	64.3 60.8	0.9	1.4	0.96	1.5			51.1 48.4	0.1	0.2	0.11	0.2
Class C -	tanuaru (+ 2011		39	1.29	57.7	1.3	2.1					40.4	0.0			0.2
		Lunda I	39 P	3.81	251.4	3.8	1.5	1.21	2.1 🗸	40	0.03	40.0	0.0	0.0	0.05	0.1 🗸
Professional 🕅 🛛 N	o Limits Belov	w 0 🗸 watts	P	3.01	201.4	3.0	1.5	3.05	1.5 -	-				-		
	Basis of Lim	its	- Ha	armonio	s Displ	av Opti	ons									
Test Method Standard	Amps (@ PF Rating		Wavef				CH	istogram			1	Tabl	e		
EN61000-4-7:1993 -	Automatic		SHE		OLTAG	F	-	equen		0	8 нл					
	1 Automatic	S					FI	equen					HARMO	DNICS	SUMN	IARY
			22	29.49	V _{rms}			Peak	at 90	.0	Deg.	PAS	SS			
			27	1 64	- ms		~				-	Cla	ssAli	mits App	vlv	
Current Range Range Up	Range D	Down Lock Range	32	24.64	Vpk		Cre	st Fac	tor 1.	41	5					
100 mA Peak			10	AD PO	WER							Actu	al Pow	er	3	8.3 W
				8.33	M				41.	68	1/0					
			-													
est Status		Free Run		88.33	W ma	ĸ	Powe	er Fac	tor 0 .	92	20	Sut	оріу ме	eets EN	Redi	iiremen
est Complete. Results Held.		1	10		RRENT											
· · · · · · · · · · · · · · · · · · ·	Hold	Abort Test			mA rm	-			17	5	2 m∆					
ALC: A TANK ALC: ALC: A				0.42	mA rm	s l	otal Ha	armoni	CS I		∠ mA					
imed Test Duration 150 Secs	Reset Me	eter Start Timed Test			mA pk			st Fac			33					

le Settings Help				
HA-PC Link Version3.01HA1600 Firmware Issue3.02			Harmonics Histogram	40mA/div
Equipment under Test				
Serial Number Tested by	1.457.451.1			
Measurement EN61000-3-2 (Harmonics)		1 Time of Test 017 11:02		
Nominal Voltage 230 Volts		Frequency 60 Hz		
Harmonics Settings			DC 5 10 15 20	25 30 35 40
	rd (>25W) to Table :	2 💌	Scale Up Scale Down	Auto-set Scale
	,			
Test Method Standard	Amps @	PF Rating	Harmonics Display Options C Waveform C Histogram	C Table
EN61000-4-7:1993 A	utomatic		SUPPLY VOLTAGE Frequency 49.98 Hz	HARMONICS SUMMARY
			229.49 V rms Peak at 90.0 Deg	
Current Range Range Up	Range Down	Lock Range	324.64 V _{pk} Crest Factor 1.415	Class A Limits Apply.
400 mA Peak			LOAD POWER 38.33 w 41.68 va	Actual Power 38.3 W
Test Status		Free Run	38.33 W max Power Factor 0.920	Supply Meets EN Requirement
Test Complete. Results Held.	Hold	Abort Test	LOAD CURRENT	
Timed Test Duration 150 Secs	Reset Meter Sta	t Timed Test	180.42 mA rms Total Harmonics 17.52 mA 222.40 mA pk Crest Factor 1.233	



Ŷ	TTI HA1600 POWER & HARMONICS ANALYSER HA-PC Link Plus				
	File Settings Help				
	HA-PC Link Version 3.01 HA1600 Firmware Issue 3.02	Waveform Graph 100mA/div			
	Equipment under Test	400 mA			
	Serial Number Tested by Measurement Date and Time of Test				
	EN61000-3-2 (Harmonics) ・ 2 六月 2017 11:02 Nominal Voltage 230 Volts Nominal Frequency ・ ・ 50 Hz 60 Hz				
	Harmonics Settings	-400 mA -400 V 0 120 240 Deg 360			
	Class C • Professional No Limits Below	I Join Dots			
$\sim C_{2}$	Basis of Limits Test Method Standard Amps @ PF Rating	Harmonics Display Options • Waveform C Histogram C Table			
	EN61000-4-7:1993	SUPPLY VOLTAGE Frequency 49.98 Hz HARMONICS SUMMARY			
	Current Range Range Up Range Down Lock Range	229.49 V rms Peak at 90.0 Deg. PASS 324.64 V pk Crest Factor 1.415 Class A Limits Apply.			
	400 mA Peak	LOAD POWER 38.33 W 41.68 VA 38.33 W 90Wer Eactor 0.020 Supply Meets EN Requirements			
		0.520 Har			
	Test Complete. Results Held. Hold Abort Test Timed Test Duration 150 Secs Reset Meter Start Timed Test	LOAD CURRENT 180.42 mA _{rms} Total Harmonics 17.52 mA 222.40 mA _{pk} Crest Factor 1.233			



7. VOLTAGE FLUCTUATIONS & FLICKER TEST

7.1.Block Diagram of Test Setup

Same as Section 6.1..

7.2. Test Standard

EN 61000-3-3:2013

7.3. Operating Condition of EUT

Same as Section 5.3.. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

Flicker Test Limit

Limits
1.0
3.3%
4.0%
Not exceed 3.3% for
500ms

7.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

7.5.Test Results

PASS

Please refer to the following page.

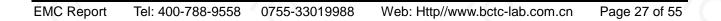


Shenzhen BCTC Testing Co., Ltd. Report No.: BCTC-FY170503280E

Flicker Test Data			
Temperature:	24.5 ℃	Relative Humidity:	54%
Pressure:	1009hPa	Phase :	Vertical
Test Voltage :	AC 230V/50Hz	Test Mode:	ON

Voltage Fluctuation	Limit	Value
Relative Voltage Change Characteristic Tmax (dc>3%)	500 ms	0 ms
	4%	0.00
Maximum Relative Voltage Change dmax	6%	180
	7%	/
Relative Steady-state Voltage Change dc	3.3%	0.00

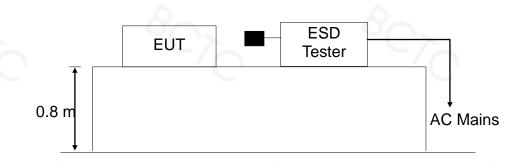
Flicker	Limit	Value
Short-term Flicker Indicator Pst	1.0	0.064
Long-term Flicker Indicator Plt	0.65	/





8. ELECTROSTATIC DISCHARGE IMMUNITY TEST

8.1.Block Diagram of Test Setup



8.2. Test Standard

EN 61547:2009, EN 61000-4-2:2009

Severity Level: 3 / Air Discharge:±8KV Level: 2 / Contact Discharge:±4KV

8.3. Severity Levels and Performance Criterion

8.3.1 Severity level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	±2	±2
2.	±4	±4
3.	±6	±8
4.	±8	±15
Х	Special	Special





8.3.2 Performance criterion : B

- A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

8.4.EUT Configuration

The following equipments are installed on Electrostatic Discharge Immunity test to meet EN 61547:2009, EN 61000-4-2:2009, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 2.4.





8.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 3.5 except the test setup replaced by Section 7.1.2.

8.6. Test Procedure

8.6.1 Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

8.6.2 Contact Discharge:

All the procedure shall be same as Section 7.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

8.6.3 Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

8.6.4 Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are complete illuminated.

8.7.Test Results

PASS

Please refer to the following page.

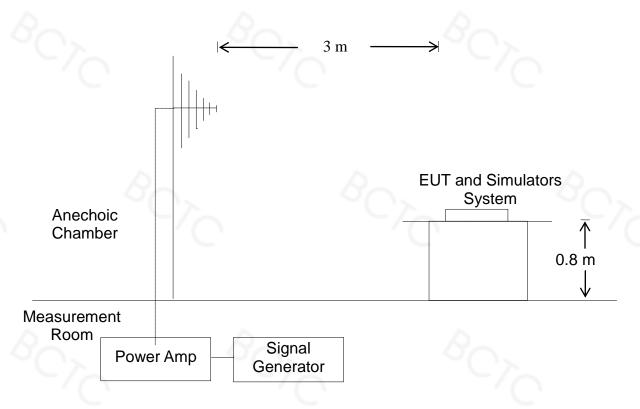


		ESD T	est Data		
Temperature:		24.5 ℃	Humidity:	Ę	53%
Power Supply : AC		C 230V/50Hz Test Mode:		On	
Air Discharge: ±8 Contact Discharge:	<∨ ± 4K\	, °C	70	°C)	
Test Points		Air Discharge	Contact Discharge	Performance Criterion	Result
Enclosure		±2,4,8KV	N/A	В	PASS
Slit	S	±2,4,8KV	N/A	В	PASS
Metal Part		N/A	±2,4 KV	В	PASS
VCP		N/A	±2,4 KV	В	PASS
HCP		N/A	±2,4 KV	В	PASS



9. RF FIELD STRENGTH SUSCEPTIBILITY TEST

9.1.Block Diagram of Test Setup



9.2. Test Standard

EN 61547:2009, EN 61000-4-3: 2006+A1:2008+A2:2010 Severity Level 2, 3V / m

9.3. Severity Levels and Performance Criterion

9.3.1. Severity level

Level	Field Strength V/m
1.	1
2.	3
3.	10
Χ.	Special



9.3.2. Performance criterion: A

- A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

9.4.EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 61547:2009, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

9.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.5 except the test setup replaced by Section 8.1.



9.6.Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

All the scanning conditions are as follows : Condition of Test

51

Remarks

- 1. Fielded Strength
- 2. Radiated Signal
- 3. Scanning Frequency
- 4. Dwell time of radiated
- 5. Waiting Time

9.7.Test Results

PASS

Please refer to the following page.

R/S Test Data Temperature : 25°C Humidity : 53% Field Strength: 3 V/m Criterion: A Power Supply: AC 230V/50Hz Frequency Range: 80 MHz to 1000 MHz 🗹 AM Modulation: □ Pulse □none 1 KHz 80% Test Mode : On Frequency Range : 80-1000MHz Steps 1 % Horizontal Result Vertical Front А Pass А Α A Pass Right Rear А А Pass Left А А Pass Note: N/A

3 V/m (Severity Level 2) Modulated 80 – 1000 MHz 0.0015 decade/s 1 Sec.



10. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

10.1. Block Diagram of EUT Test Setup



10.2. Test Standard

EN 61547:2009, EN 61000-4-4:2012

10.3. Severity Levels and Performance Criterion

Severity Level 2 at 1KV, Pulse Rise time & Duration: 5 nS / 50 nS Severity Level:

Open Circuit Output Test Voltage ±10%			
Level	On power ports	On I/O(Input/Output)	
		Signal data and control ports	
1.	0.5KV	0.25KV	
2.	1KV	0.5KV	
3.	2KV	1KV	
4.	4KV	2KV	
Χ.	Special	Special	

Performance criterion: B

- A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.



Report No.: BCTC-FY170503280E

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

10.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 61547:2009, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

10.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.6 except the test setup replaced by Section 9.1.

10.6. Test Procedure

EUT shall be placed 0.8m high above the ground reference plane which is a min.1m*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m

9.6.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 minutes.

10.7. Test Results

PASS

Please refer to the following page.



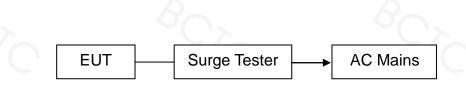
		EFT Te	est Data				
Temperature:	24.5°C Humidity: 55		53	53%			
Power Supply :	AC 230V/50Hz	Test Mo	de:	Or	n		
00		NC			50		
	Tes	t Voltage	10		Performance	Result	
Coupling Line	±0.5kV		±1kV		Criterion		
L	±0.5kV		±1kV		В	PASS	
N	±0.5kV		±1kV	3	В	PASS	
L-N	±0.5kV	2	±1kV		В	PASS	
PE	±0.5kV		±1kV		В	N/A	
L-PE	±0.5kV	~	±1kV		В	N/A	
N-PE	±0.5kV	0	±1kV		В	N/A	
L-N-PE	±0.5kV		±1kV		В	N/A	
DC Line	/		/			/	

Note: N/A



11. SURGE TEST

11.1. Block Diagram of EUT Test Setup



11.2. Test Standard

EN 61547:2009, EN61000-4-5:2014

11.3. Severity Levels and Performance Criterion

Severity Level:	Line to Line, Level 2 at 1KV;
Severity Level:	Line to Earth, Level 3 at 2KV.

Severity Level	Open-Circuit Test Voltage (KV)
1.	0.5
2.	1.0
3.	2.0
4.	4.0
Χ.	Special

Performance criterion: B

- A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.



Report No.: BCTC-FY170503280E

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

11.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 61547:2009, EN61000-4-5:2014, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

11.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.7 except the test setup replaced by Section 10.1.

11.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 10.1
- 2) For line to line coupling mode, provide a 1KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 4) Different phase angles are done individually.
- 5) Repeat procedure 2) to 4) except the open-circuit test voltage change from 1KV to 2KV for line to earth coupling mode test.
- 6) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

11.7. Test Result

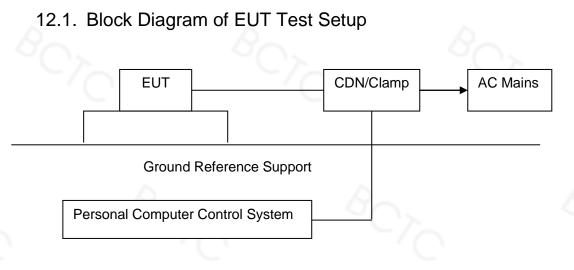
PASS



	53%		
~	~	On	
0	Perforr Crite	mance rion	Resu
		\sim	Pass
			N/A
			N/A
			Pass
			N/A
			N/A
2	В	N/A	
0			N/A
			N/A
			N/A
			N/A
~			N/A
- <	(3	30.



12. INJECTED CURRENTS SUSCEPTIBILITY TEST



12.2. Test Standard

EN 61547:2009, EN61000-4-6:2014

12.3. Severity Levels and Performance Criterion

Severity Level 2: 3V(rms), 150KHz $\,\sim\,$ 80MHz Severity Level:

Level	Field Strength V
1.	1
2.	3
3.	10
Х.	Special

Performance criterion: A

A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.



Report No.: BCTC-FY170503280E

B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

12.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.8.

12.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.8 except the test set up replaced as Section 11.1.

12.6. Test Procedure

- 1) Set up the EUT, CDN and test generator as shown on section 11.1
- 2) Let EUT work in test mode and measure.
- 3) The EUT and supporting equipments are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane at above 0.1-0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- 4) The disturbance signal described below is injected to EUT through CDN.
- 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.



Report No.: BCTC-FY170503280E

- 6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave
- 7) The rate of sweep shall not exceed 1.5×10⁻³ decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 8) Recording the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.
- 12.7. Test Result

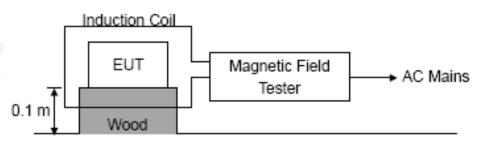
PASS

			CS Test Data				
Tempera	ature:	24	1.5℃	Humid	lity:	5	3%
Power St	upply :	AC 23	0V/50Hz	Test Mo	ode:	(Dn
Frequency Range(MHz)	Injected Position	Strength	Modulation Signal	Freq. Step		rmance erion	Result
$150 { m KHz} \sim 80 { m MHz}$	AC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%		A	Pass
$150 { m KHz} \sim 80 { m MHz}$	DC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%		/	/
Note: N/A	6		8	0			80



13. MAGNETIC FIELD IMMUNITY TEST





Ground Reference Support

13.2. Test Standard

EN 61547:2009, EN61000-4-8:2010 Severity Level 1 at 1A/m

- 13.3. Severity Levels and Performance Criterion
 - 13.3.1 Severity level

Level	Magnetic Field Strength A/m
1.	<u>(</u> 1
2.	3
3.	10
4.	30
5.	100
Х.	Special

13.3.2 Performance criterion: B

A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.



B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

13.4. EUT Configuration on Test

The configuration of EUT is listed in Section 2.9.

13.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.9 except the test set up replaced as Section 12.1.

13.6. Test Procedure

The EUT shall be subjected to the test magnetic field by using the induction coil of standard dimensions (1m*1m) and shown in Section 10.1. The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

13.7. Test Results

PASS

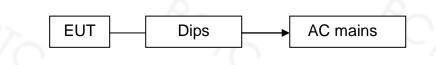


	M	S Test Data				
Temperature:	24.5	24.5°C		y:	53%	
Power Supply :	AC 230	//50Hz	Test Mod	le:	On	
Environmental Phenomena	Test specification	Units	Coil Orientation	Performa ce Criterio	Result	
			x	A	PASS	
Magnetic Field	3	A/m	Y	А	PASS	
	S_{\odot}	4	z	А	PASS	



14. VOLTAGE DIPS AND INTERRUPTIONS TEST

14.1. Block Diagram of EUT Test Setup



14.2. Test Standard

EN 61547:2009, EN61000-4-11:2004

14.3. Severity Levels and Performance Criterion

Severity Level:

Input and Output AC Power Ports.

- ☑ Voltage Dips.
- ☑ Voltage Interruptions.

Environmental	Test Specification	Units	Performance
Phenomena	\sim \sim \sim \sim	\sim (Criterion
\frown	70	% Reduction	C
Voltage Dips	10	period	C
	0	% Reduction	D
	0.5	period	Б

Performance criterion: C, B

- A. The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- B. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaces by a permissible loss of performance.



During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably except from the equipment if used as intended.

C. Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

14.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.10.

14.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.10 except the test set up replaced as Section 13.1.

14.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 13.1
- 2) The interruption is introduced at selected phase angles with specified duration. There is a 3mins minimum interval between each test event.
- 3) After each test a full functional check is performed before the next test.
- 4) Repeat procedures 2 & 3 for voltage dips, only the level and duration is changed.
- 5) Record any degradation of performance.

14.7. Test Result

PASS



	DIPS Test Data		
Temperature:	24.5°C	Humidity:	53%
Power Supply :	AC 230V/50Hz	Test Mode:	On
Environmental Phenomena	Test Specification	Units	Performance Criterion
Voltage Dine	70 10	% Reduction period	С
Voltage Dips	0 0.5	% Reduction period	в

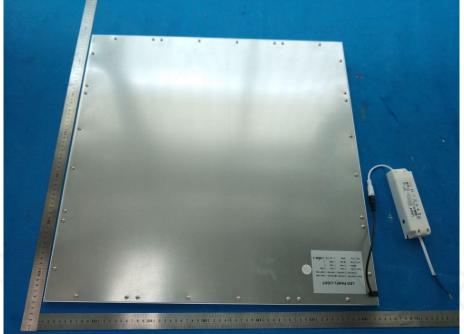


15. EUT PHOTOGRAPHS

EUT Photo 1



EUT Photo 2









16. EUT TEST PHOTOGRAPHS

CE



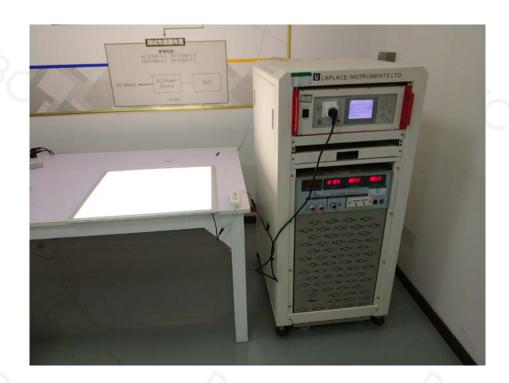
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Report No.: BCTC-FY170503280E

HF



ESD

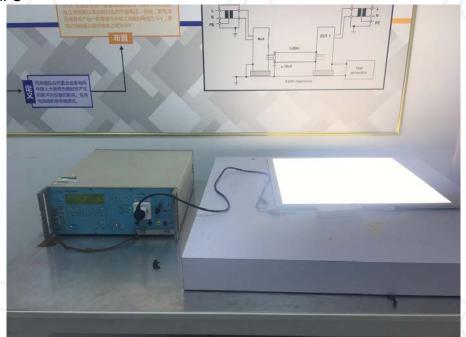




RS



Surge&EFT&DIPS





CS

Shenzhen BCTC Testing Co., Ltd.

Report No.: BCTC-FY170503280E

**** END OF REPORT ****